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January 2007

FDY3000NZ

Dual N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

This Dual N-Channel MOSFET has been designed using Fairchild Semiconductor's advanced Power Trench process to optimize the $R_{\text{DS(ON)}} \textcircled{Q} \ V_{\text{GS}} = 2.5 \text{v}.$

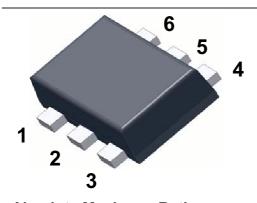
Applications

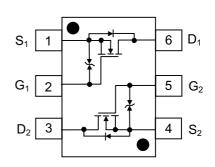
• Li-Ion Battery Pack



Features

- 600 mA, 20 V $R_{DS(ON)}$ = 700 m Ω @ V_{GS} = 4.5 V $R_{DS(ON)}$ = 850 m Ω @ V_{GS} = 2.5 V
- ESD protection diode (note 3)
- RoHS Compliant





Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain-Source Voltage		20	V
V_{GSS}	Gate-Source Voltage		± 12	V
I _D	Drain Current - Continuous	(Note 1a)	600	mA
	– Pulsed		1000	
P _D	Power Dissipation (Steady State)	(Note 1a)	625	mW
		(Note 1b)	446	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	200	°C/W
Rain	Thermal Resistance, Junction-to-Ambient (Note 1b)	280	

Package Marking and Ordering Information

Device Marking		Device	Reel Size	Tape width	Quantity	
	С	FDY3000NZ	7 "	8 mm	3000 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			•		
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	20			V
<u>ΔBVpss</u> ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, Referenced to 25°C		14		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 16 V, V _{GS} = 0 V			1	μА
I_{GSS}	Gate-Body Leakage,	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			± 10	μΑ
		$V_{GS} = \pm 4.5 \text{ V}, V_{DS} = 0 \text{ V}$			± 1	μА
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.6	1.0	1.3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		-3		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$ \begin{vmatrix} V_{GS} = 4.5 \text{ V}, & I_D = 600 \text{ mA} \\ V_{GS} = 2.5 \text{ V}, & I_D = 500 \text{ mA} \\ V_{GS} = 1.8 \text{ V}, & I_D = 150 \text{ mA} \\ V_{GS} = 4.5 \text{ V}, & I_D = 600 \text{mA}, & T_J = 125 ^{\circ}\text{C} \\ \end{vmatrix} $		0.25 0.37 0.73 0.35	0.70 0.85 1.25 1.00	Ω
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 600 \text{ mA}$		1.8		S
Dvnamio	Characteristics					
C _{iss}	Input Capacitance	V _{DS} = 10 V, V _{GS} = 0 V,		60		pF
Coss	Output Capacitance	f = 1.0 MHz		20		pF
C _{rss}	Reverse Transfer Capacitance	1		10		pF
Switchin	g Characteristics (Note 2)	,				
t _{d(on)}	Turn-On Delay Time	V _{DD} = 10 V, I _D = 1 A,		6	12	ns
t _r	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$		8	16	ns
t _{d(off)}	Turn-Off Delay Time			8	16	ns
t _f	Turn–Off Fall Time			2.4	4.8	ns
Qg	Total Gate Charge	V _{DS} = 10 V, I _D = 600 mA,		0.8	1.1	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 4.5 V		0.16		nC
Q_{gd}	Gate-Drain Charge	<u> </u>		0.26		nC
Drain-Se	ource Diode Characteristics	and Maximum Ratings				
V _{SD}	Drain–Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 150 mA (Note 2)		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 600 mA,		8		nS
Q _{rr}	Diode Reverse Recovery Charge	dl _ε /dt = 100 A/μs		1		nC

Notes:
1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design



200°C/W when mounted on a 1in² pad of 2 oz copper



- b) 280°C/W when mounted on a minimum pad of 2 oz copper Scale 1 : 1 on letter size paper
- 2. Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%
- The diode connected between the gate and source serves only as protection againts ESD. No gate overvoltage rating is implied.

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Typical Characteristics

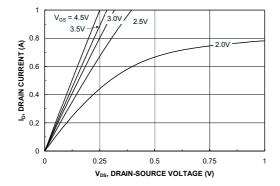


Figure 1. On-Region Characteristics.

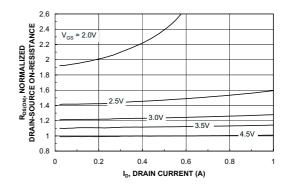


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

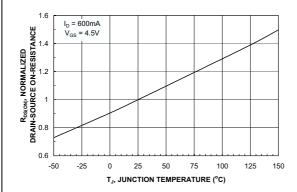


Figure 3. On-Resistance Variation with Temperature.

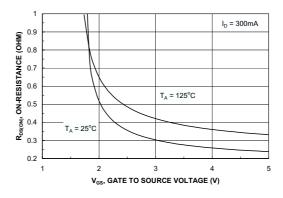


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

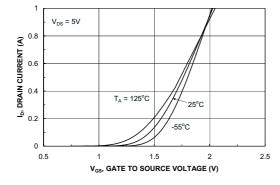


Figure 5. Transfer Characteristics.

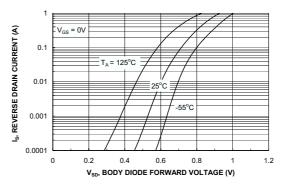
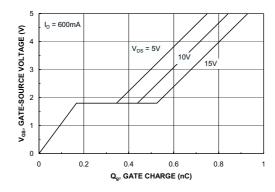


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

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Typical Characteristics



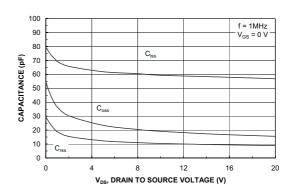


Figure 7. Gate Charge Characteristics.

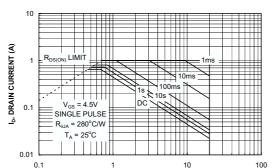


Figure 8. Capacitance Characteristics.

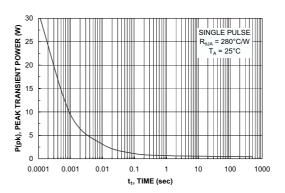


Figure 9. Maximum Safe Operating Area.

V_{DS}, DRAIN-SOURCE VOLTAGE (V)



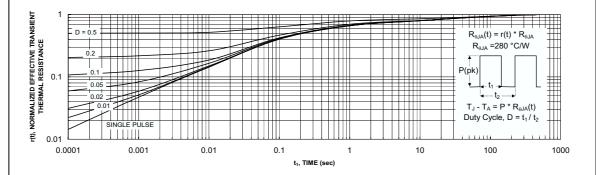
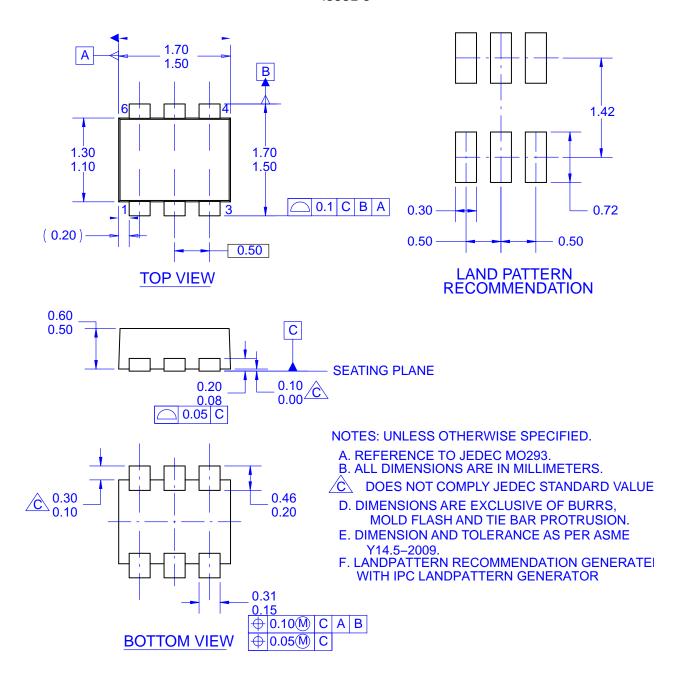


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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